## Abstract Submitted for the MAR15 Meeting of The American Physical Society

Phase transition of MoS<sub>2</sub> using laser irradiation<sup>1</sup> JAESU KIM, JUNSUK KIM, JINHEE LEE, YOUNGJO JIN, TAESOO KIM, YOUNG HEE LEE, SEONG CHU LIM, Institute for Basic Science, Center for Intgrated Nanostructure physics, Department of Energy Science, Sungkyunkwan University, Suwon 440-746—The multi-layer 2H- MoS<sub>2</sub> flakes are transferred toSiO<sub>2</sub>/Si substrate by mechanical exfoliation method and transformed into 1T-MoS<sub>2</sub> by Li intercalation. The phase change by Li doping leads semiconducting 2H-MoS<sub>2</sub> to metallic 1T-MoS<sub>2</sub> that is confirmed by Raman and PL spectroscopy and I-V measurements. Then, 1T-MoS<sub>2</sub> flakes are locally heated to recover to 2H-MoS<sub>2</sub> using 532nm-laser beam that can increase the irradiated power up to 10 mW. The characteristics of thermally patterned 2H-MoS<sub>2</sub> are investigated by confocal PL and photo-current and I-V measurements. Also, the junction characteristics of 2H- and 1T-MoS<sub>2</sub> flakes will be discussed further in this presentation.

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